

FDR4420A

Single N-Channel, Logic Level, PowerTrench™ MOSFET

General Description

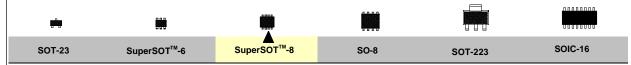
The SuperSOT-8 family of N-Channel Logic Level MOSFETs have been designed to provide a low profile, small footprint alternative to industry standard SO-8 little foot type product.

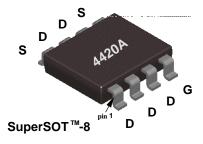
These MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been tailored to minimize the on-state resistance and yet maintain superior switching performance.

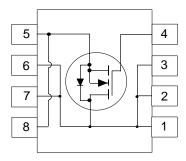
These devices are well suited for low voltage and battery powered applications where small package size is required without compromising power handling and fast switching.

Features

- 11 A, 30 V. $R_{DS(ON)} = 0.009 \Omega$ @ $V_{GS} = 10 \text{ V}$, $R_{DS(ON)} = 0.013 \Omega$ @ $V_{GS} = 4.5 \text{ V}$.
- Fast switching speed.
- Low gate charge.
- Small footprint 38% smaller than a standard SO-8.
- Low profile package(1mm thick).
- Power handling capability similar to SO-8.





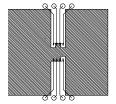


Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

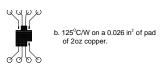
Symbol	Parameter		FDR4420A	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
D	Draint Current - Continuous	(Note 1a)	11	A
	- Pulsed		40	
P _D	Maximum Power Dissipation	(Note 1a)	1.8	W
		(Note 1b)	1	
		(Note 1c)	0.9	
$\Gamma_{\rm J}$, $T_{\rm STG}$	Operating and Storage Temperature	e Range	-55 to 150	°C
THERMA	L CHARACTERISTICS	·		<u>.</u>
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient (Note 1a)		70	°C/W
R _{euc}	Thermal Resistance, Junction-to-Ca	ase (Note 1)	20	°C/W

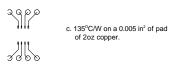
Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I _D = 250 μA, Referenced to 25 °C			20		mV /°C
DSS	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V				1	μA
			T _J = 55°C			10	μA
GSS	Gate - Body Leakage Current	$V_{GS} = 20 \text{ V}, \ V_{DS} = 0 \text{ V}$	•			100	nA
GSS	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \ V_{DS} = 0 \text{ V}$				-100	nA
ON CHARA	CTERISTICS (Note 2)			•			•
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp.Coefficient	$I_D = 250 \mu A$, Referenced t	o 25°C		-6		mV /°C
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1	1.4	3	V
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 11 \text{ A}$			0.0075	0.009	Ω
,			T _J =125°C		0.0125	0.016	
		$V_{GS} = 4.5 \text{ V}, I_{D} = 9 \text{ A}$			0.01	0.013	
D(ON)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \ V_{DS} = 5 \text{ V}$		30			Α
Fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 11 \text{ A}$			25		S
DYNAMIC (HARACTERISTICS						•
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, \ V_{GS} = 0 \text{ V},$ f = 1.0 MHz			2560		pF
Coss	Output Capacitance				560		pF
C _{rss}	Reverse Transfer Capacitance				280		pF
SWITCHING	CHARACTERISTICS (Note 2)						
D(on)	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, \ I_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \ R_{GEN} = 1 \Omega$			11	20	ns
r	Turn - On Rise Time				15	27	ns
D(off)	Turn - Off Delay Time				25	40	ns
f	Turn - Off Fall Time				21	34	ns
\mathbf{Q}_{g}	Total Gate Charge	$V_{DS} = 15 \text{ V}, \ I_D = 9.3 \text{ A}, \ V_{GS} = 5 \text{ V}$			23	33	nC
Q_{gs}	Gate-Source Charge				7		nC
Q_{gd}	Gate-Drain Charge				11		nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND N	MAXIMUM RATINGS					
s	Maximum Continuous Drain-Source Diode Forward Current				1.5	Α	
V _{SD}	Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 1.5 \text{ A} \text{ (Note 2)}$			0.7	1.2	V	

1. $R_{g,a}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,c}$ is guaranteed by design while $R_{g,c,h}$ is determined by the user's board design. $R_{g,s,h}$ shown below for single device operation on FR-4 board in still air.



a. 70°C/W on a 1 in² pad of 2oz copper.





Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

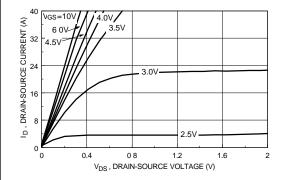


Figure 1. On-Region Characteristics.

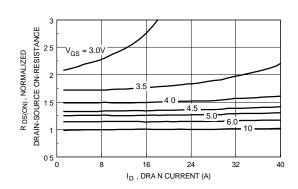


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

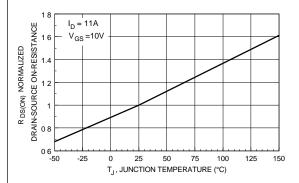


Figure 3. On-Resistance Variation with Temperature.

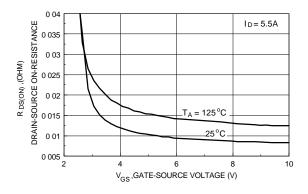


Figure 4. On Resistance Variation with Gate-To-Source Voltage.

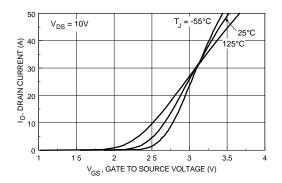


Figure 5. Transfer Characteristics.

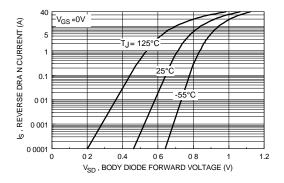
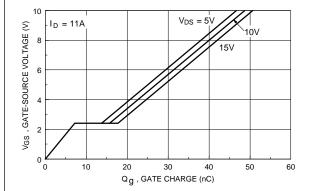


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Electrical Characteristics (continued)



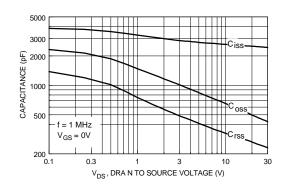
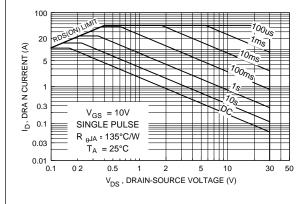


Figure 7. Gate Charge Characteristics.





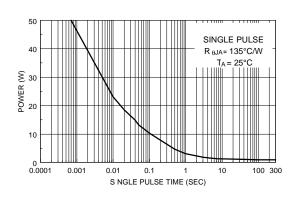


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

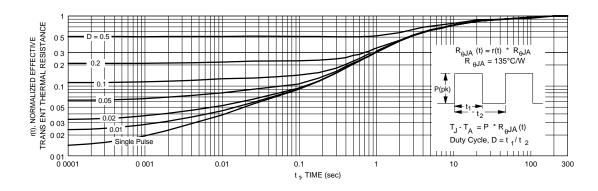


Figure 11.Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in note 1c.

Transient thermal response will change depending on the circuit board design.

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